

# ANGI095105-P49

# X-Band matched GaN Device

#### **Features:**

Frequency:  $9.5 \sim 10.5$  GHz Saturated Output Power:  $P_{sat} \geq 49$  dBm PowerGain: Gain  $\geq 8.5$  dB Add-Efficiency: PAE  $\geq 35\%$ Port Matching:  $Z_{in}/Z_{out} = 50\Omega$ 

### **Description**:

ANGI095105-P49 is an internal matching GaN device, which adopts advanced co-planar internal matching MCM and thin film circuit technology. The typical working frequency range is 9.5~10.5GHz. This device can be used in different RF/Microwave system and subsystem.

The high output power level, high efficiency and wide operating temperature range can make application very flexible.

# Maximun Ratings (TC=25°C, Not recommended working under this condition):

	Symbol	Value	Unit
Voltage between source and drain	Vds	40	V
Voltage between gate and source	Vgs	-5	V
Storage Temperature Range	Tstg	-65 to +175	°C
Drain and Source Channel Temperature	Tch	175	°C

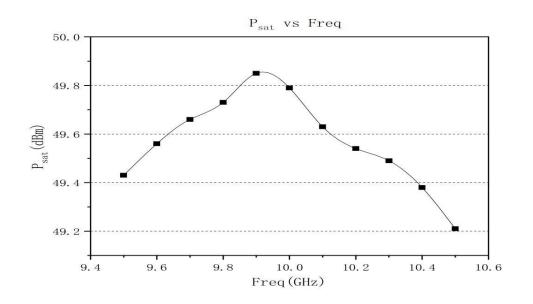
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# **Electrical Characteristics:**

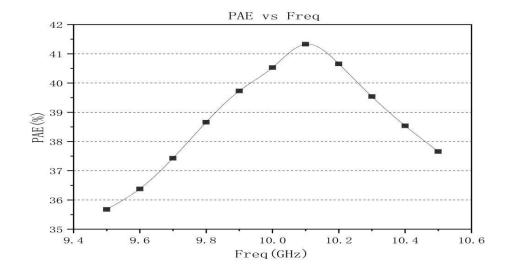
		Value				
	Symbol	Test condition	Min	Тур	Max	Unit
Drain Current	ldsr		-	7	-	А
Saturated Output Power	Psat	Vds=28V PW. T=1ms, Duty=10% Pin: 40.5dBm Freq: 9.5~10.5GHz	49	-	-	dBm
Gain	Gp		8.5	-	-	dB
Add-Efficiency	PAE		35	-	-	%
Gain Flatness	ΔG		-0.8	-	+0.8	dB

# **Typical Curve:**

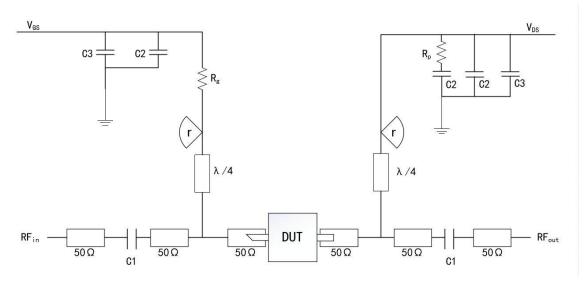


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## **Application Circuit:**



DUT: Device to be tested

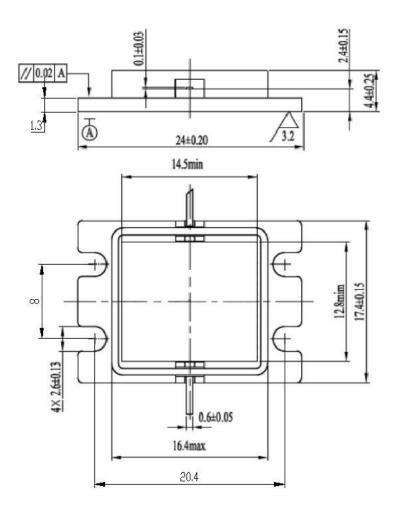
C1:1pF	R <sub>p</sub> :51Ω
C2:1000pF	R <sub>G</sub> :15Ω
C3:100uF	r(radius)≈3.5mm(Rogers5880, 20mil)



#### **ESD Level:**



#### **Outline:**



#### **Precautions for use:**

- Pay attention to drying transportation and storage.
- Pay attention to anti-static during chip use and assembly, and wear grounding anti-static bracelet.
- When powering up, first apply grid power then add leakage.

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